


<b>Search Notes</b>  	<b>Application/Control No.</b>  10661816	<b>Applicant(s)/Patent Under Reexamination</b>  MUCHOW ET AL.
	<b>Examiner</b>  Kaplan, Hal I	<b>Art Unit</b>  2836

SEARCHED			
Class	Subclass	Date	Examiner
307	72	3/12/2007	HK
320	101	3/12/2007	HK

SEARCH NOTES		
Search Notes	Date	Examiner
EAST (US-PGPUB,USPAT,USOCR,FPRS,EPO,JPO,DERWENT,IBM_TDB) - See Search History Printout	3/12/2007	HK
361/600+; 220/\$ (consulted Boris Chervinsky)	10/19/2006	HK
290/\$ (consulted Joseph Waks)	10/20/2006	HK

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
Interference Search History Printout		3/12/2007	HK